



# EMC Test Report

**Product Name: LTE USB Stick**

**Model Number: E3272s-506**

**Report No: SYBH(Z-EMC)098072013-2**

**FCC ID: QISE3272S-506**

**Reliability Laboratory of Huawei Technologies Co., Ltd.**

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## Notice

1. The laboratory has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L0310.
2. The laboratory has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
3. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
4. The laboratory has been listed by industry Canada to perform electromagnetic emission measurement. The site recognition number is 6369A-2.
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**Applicant:** Huawei Technologies Co., Ltd.

**Address:** Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

**Date of Receipt Test Item:** Jul.29.2013

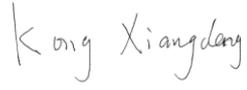
**Start Date of Test:** Aug.01.2013

**End Date of Test:** Aug.05.2013

**Test Result:** Pass

**Approved By (Lab Manager)**      2013-08-21      Liu Chunlin      

**Date**      **Name**      **Signature**

**Prepared by (Test Engineer)**      2013-08-21      Kong Xiangdeng      

**Date**      **Name**      **Signature**



## TABLE OF CONTENT

1	General Information .....	5
1.1	EUT Description .....	5
1.2	Test Site Information .....	6
1.3	Applied Standards .....	6
2	Summary of Results .....	7
3	System Configuration during EMC Test.....	8
3.1	Test Mode.....	8
3.2	Test System Configuration .....	8
3.3	Cables Used during Test.....	9
3.4	Associated Equipment Used during Test.....	9
4	Electromagnetic Interference (EMI) .....	10
4.1	Radiated Disturbance 30MHz to 18GHz.....	10
4.2	Conducted Disturbance 0.15 MHz to 30MHz.....	12
5	Main Test Instruments .....	13
6	System Measurement Uncertainty .....	14
7	Test Data and Graph .....	15
7.1	Radiated Disturbance .....	15
7.2	Conducted Disturbance.....	17

## 1 General Information

### 1.1 EUT Description

EUT Description	
Product Name	LTE USB Stick
Model Number	E3272s-506
Input voltage	5V
TX Frequency	GSM 850:824 MHz To 849 MHz GSM1900:1850MHz To 1910MHz WCDMA BAND II:1850 MHz To 1910 MHz WCDMA BAND IV:1750 MHz To 1755 MHz WCDMA BAND V: 824 MHz To 849 MHz LTE BAND II: 1850 MHz To 1910 MHz LTE BAND IV: 1750 MHz To 1755 MHz LTE BAND V: 824 MHz To 849 MHz LTE BAND VII: 2500 MHz To 2570 MHz
RX Frequency	GSM850:869MHz To 894MHz GSM1900:1930MHz To 1990MHz WCDMA BAND II:1930 MHz To 1990 MHz WCDMA BAND IV:2110 MHz To 2155 MHz WCDMA BAND V: 869MHz To 894MHz LTE BAND II:1930 MHz To 1990 MHz LTE BAND IV:2110 MHz To 2155 MHz LTE BAND V: 869MHz To 894MHz LTE BAND VII: 2620 MHz To 2690 MHz
S/N	S7C01A9372200175
HW Version	CH1E3272SM
SW Version	21.436.05.05.00
EUT Accessory	
Data cable	Data Cable USB A Male to Micro USB, shielded

Remark: The above EUT's information is declared by manufacturer. Please refer to the specifications or user's manual for more detailed information.



## 1.2 Test Site Information

Test Site:	RELIABILITY LABORATORY OF HUAWEI TECHNOLOGIES CO., LTD.
Test Site Location:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

## 1.3 Applied Standards

APPLIED STANDARD

47 CFR FCC Part 15:2012, Subpart B

## 2 Summary of Results

Summary of Results				
Test Items	Test Mode	Performance Class & Required Performance Criteria	Result	Site
Radiated Emissions Enclosure Port	Mode 2 Mode 4	CLASS B	Pass	Site1
Conducted Emissions <input checked="" type="checkbox"/> DC Power Port <input checked="" type="checkbox"/> AC Power Port <input type="checkbox"/> Telecommunication Ports	Mode 1~Mode 2	CLASS B	Pass	Site1
Note: 1, Measurement taken is within the measurement uncertainty of measurement system. 2, <input checked="" type="checkbox"/> The item has been tested; <input type="checkbox"/> The item has not been tested.				

During the measurement, the environmental conditions complied with the range listed as below.

Item	Required
Ambient temperature	15°C ~ 35°C
Relative humidity	25% ~ 75%
Atmospheric pressure	86kPa ~ 106kPa

### 3 System Configuration during EMC Test

#### 3.1 Test Mode

Huawei has verified the construction and function in typical operation. All the test modes were carried out with the EUT under normal operation, which were shown in this test report and defined as below:

Test Mode	
Mode 1:	USB Copy(EUT with PC)+ Traffic
Mode 2:	USB Copy(EUT with PC)+Idle
Mode 3:	USB Cable + USB Copy(EUT with PC)+ Traffic
Mode 4:	USB Cable + USB Copy(EUT with PC)+Idle

Remark:

- 1) If there is one kind of accessories with different models, each one should be applied throughout the compliance test respectively, however, only the worst case will be recorded in this report.
- 2) If EUT has more than one typical operation, only the worst test mode will be recorded in this report.

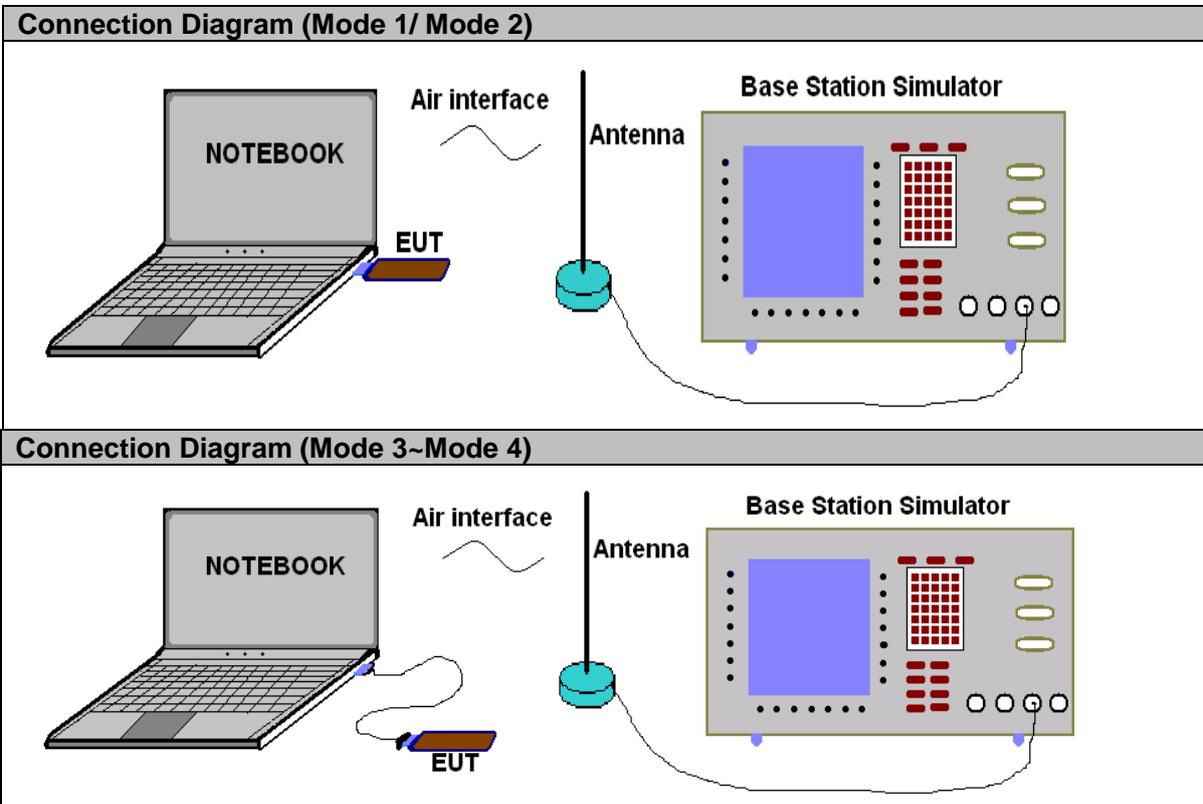
Traffic Mode:

When the EUT state is switched on and with Radio Resource Control (RRC) connection established.

Idle Mode:

When the EUT state is switched on but without Radio Resource Control (RRC) connection.

#### 3.2 Test System Configuration





### 3.3 Cables Used during Test

Cable	Quantity	Length	Type of Cable
USB	1	<3m	shielded

### 3.4 Associated Equipment Used during Test

Name	Model	Manufacturer	S/N	Calibrated Deadline	Cal interval (month)
Radio Communication Tester	CMU200	R&S	117057	2013-09-22	12
Radio Communication Tester	MT8820C	Anritsu	6200971028	2014-05-06	12
Notebook	X200	ThinkPad	31090403588	/	/

## 4 Electromagnetic Interference (EMI)

### 4.1 Radiated Disturbance 30MHz to 18GHz

#### 4.1.1 Test Procedure

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4dB according to the standards: ANSI C63.4-2009. The test distance was 3m. The set-up and test methods were according to ANSI C63.4-2009.

A preliminary scan and a final scan of the emissions were made from 30 MHz to 18 GHz by using test script of software; The emissions were measured using Quasi-Peak Detector (30MHz~1GHz) and AV/PK detector (above 1GHz). The maximal emission value was acquired by adjusting the antenna height, polarisation and turntable azimuth in accordance with the software setup. Normally, the height range of antenna was 1m to 4m. The azimuth range of turntable was 0° to 360°. The receiving antenna has two polarizations V and H.

Measurement bandwidth (RBW) for 30MHz to 1000 MHz: 120 kHz;

Measurement bandwidth (RBW) for 1000MHz to 18000 MHz: 1MHz;

EUT was configured in idle mode and the test performed at worst emission state.

#### 4.1.2 Test setup

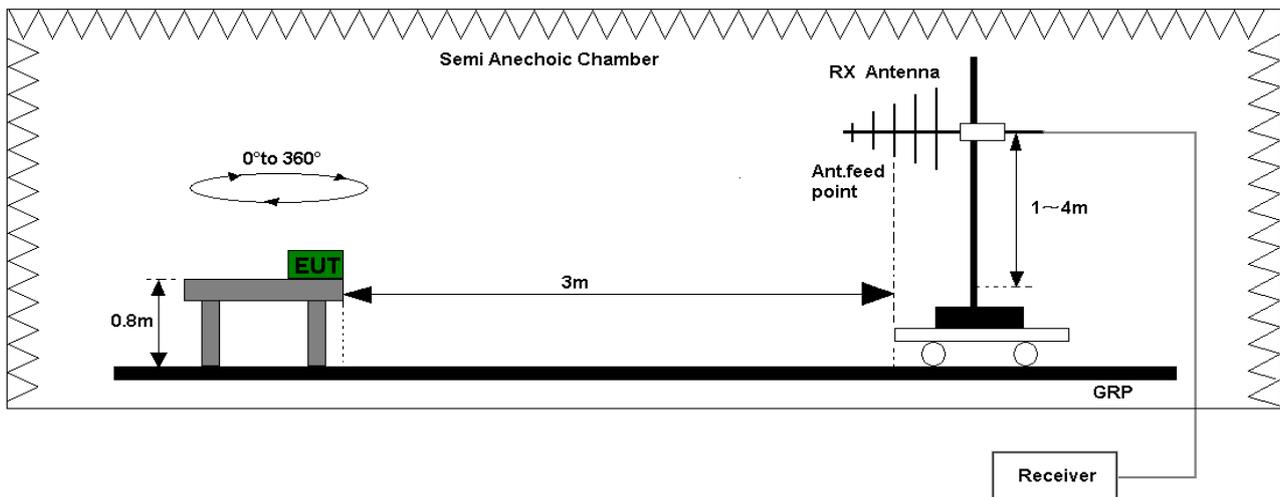


Figure 1. Test set-up of radiated disturbance(30MHz-1GHz )

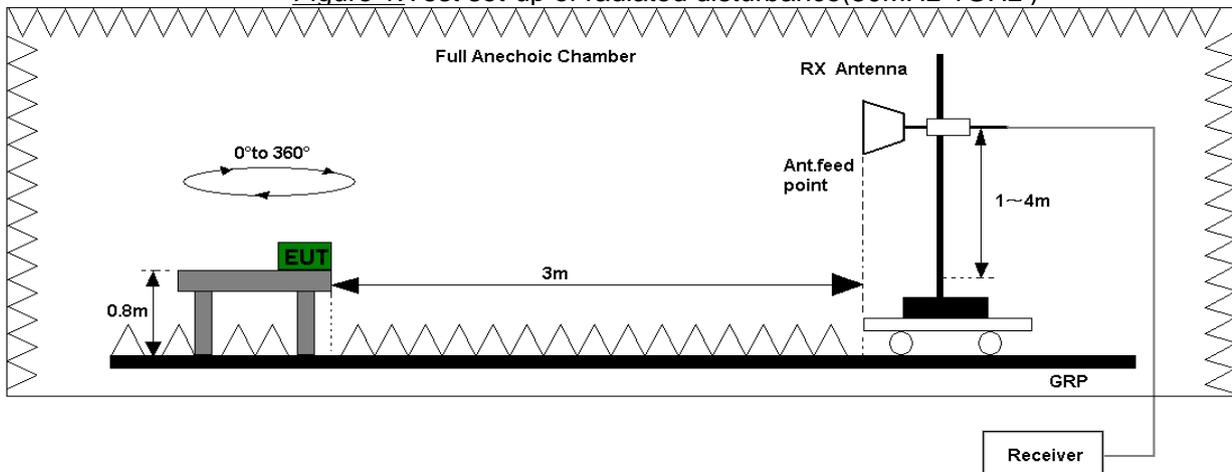


Figure 2. Test set-up of radiated disturbance(above 1GHz)



### 4.1.3 Test Results

The EUT has met the requirements for Radiated Emission of enclosure port.  
Refer to the section 7.1 of this report for test data..

Test Limits (Class B)				
Frequency of Emission (MHz)	Radiated Limit			
	Unit( $\mu$ V/m)		Unit(dB $\mu$ V/m)	
30-88	100		40	
88-216	150		43.5	
216-960	200		46	
Above 960	500		54	
Above 1000	AV	PK	AV	PK
	500	5000	54	74

## 4.2 Conducted Disturbance 0.15 MHz to 30MHz

### 4.2.1 Test Procedure

The Table-top EUT was placed upon a non-metallic table 0.8 m above the horizontal metal reference ground plane. EUT was connected to LISN and LISN was connected to reference Ground Plane. EUT was 80cm away from LISN. The set-up and test methods were according to ANSI C63.4-2009. Conducted Disturbance at AC Port measurements were undertaken on the L and N Lines. The emissions were measured using a Quasi-Peak Detector and Average Detector.

EUT was communicated with the simulator through Air interface, the simulator controls the EUT to transmitter the maximum power which defined in specification of product. The EUT operated on the typical channel.

Measurement bandwidth (RBW) for 150 kHz to 30 MHz: 9 kHz;

The EUT was set in the shielded chamber and operated under nominal conditions.

### 4.2.2 Test Setup

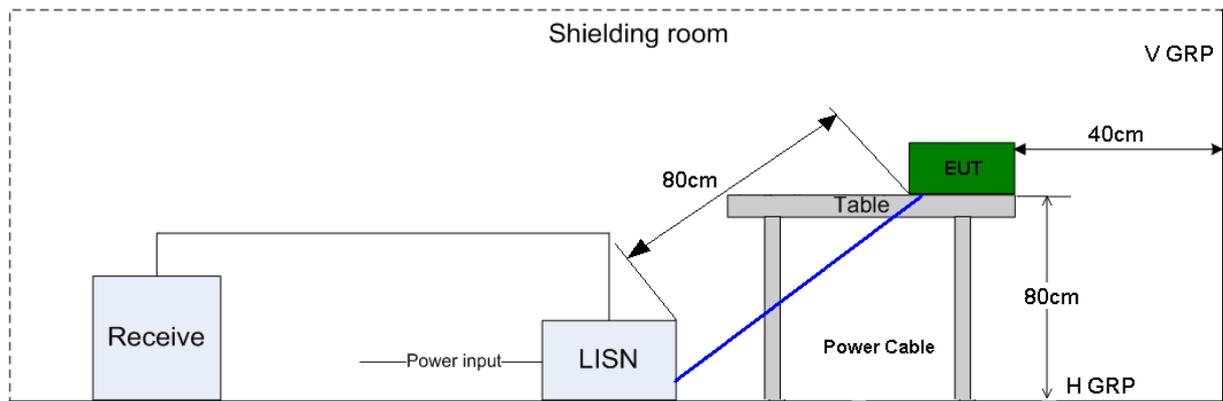


Figure 3. Test Set-up of conducted disturbance

### 4.2.3 Test Results

The EUT has met requirements for Conducted disturbance.  
Refer to the section 7.2 of this report for test data.

Test Limit of AC Power Port		
Frequency range	150kHz ~ 30MHz	
Frequency	Voltage limits	
	QP	AV
0.15MHz~0.5MHz	66-56dB $\mu$ V	56-46 dB $\mu$ V
0.5MHz-5MHz	56dB $\mu$ V	46 dB $\mu$ V
5MHz~30MHz	60dB $\mu$ V	50 dB $\mu$ V

## 5 Main Test Instruments

Main Test Equipments						
Test item	Test Instrument	Model	S/N	Manufacturer	Calibrated deadline	Cal interval (month)
RE	EMI Test receiver	ESU26	100150	R&S	May.14, 2014	12
	Broadband Antenna	VULB 9163	9163-356	SCHWARZBECK	May.27 2014	24
	Horn Antenna	HF906	100683	R&S	Feb.01, 2015	24
CE	EMI Test receiver	ESCI	101163	R&S	Jan. 28, 2014	12
	Artificial Mains Network	ENV216	100382	R&S	Jan. 28, 2014	12
Software Information						
Test Item	Software Name		Manufacturer		Version	
RE	ES-K1		R&S		1.7.1	
CE	EMC32		R&S		V8.40.0	

## 6 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

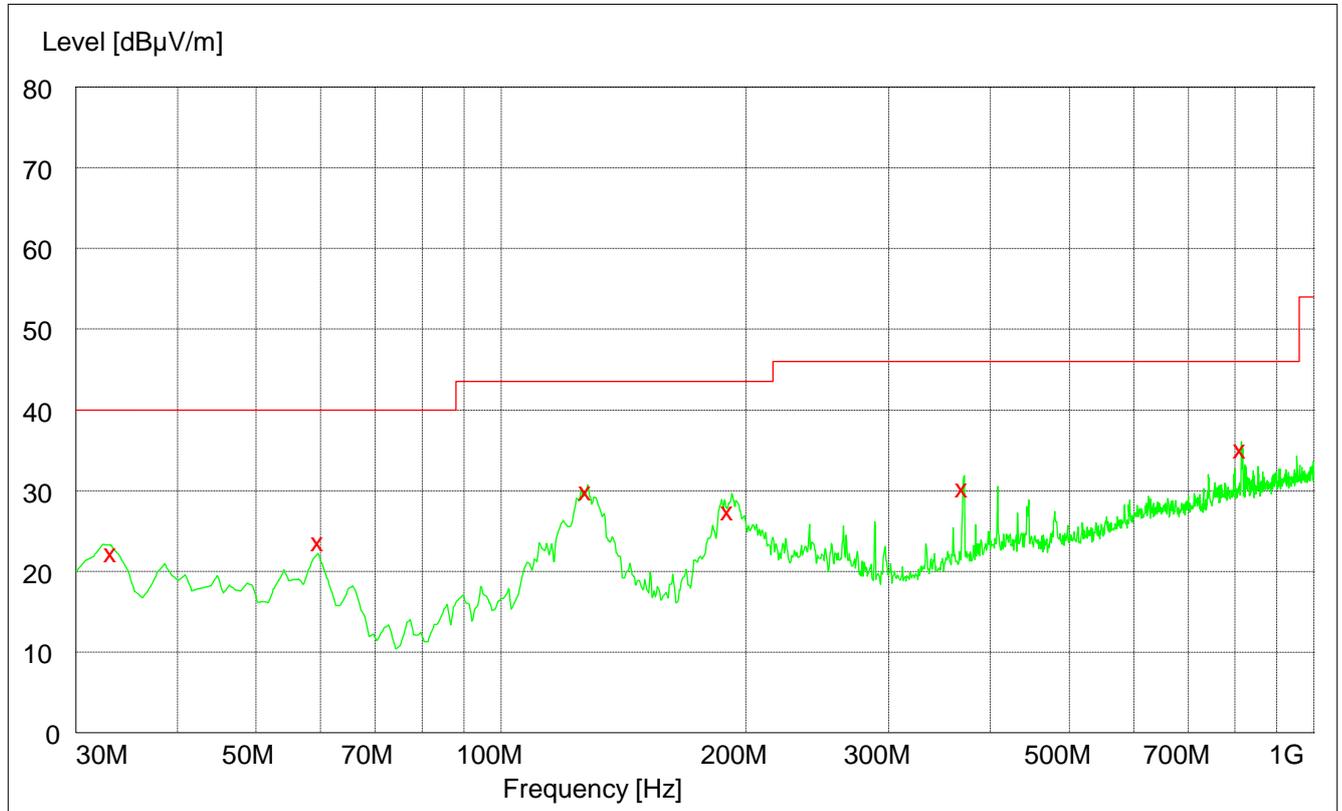
System Measurement Uncertainty		
	Items	Extended Uncertainty
RE(30MHz-1GHz)	Field strength (dB $\mu$ V/m)	U=4.1dB; k=2
RE(1GHz-18GHz)	Field strength (dB $\mu$ V/m)	U=5.1dB; k=2
CE	Disturbance Voltage (dB $\mu$ V)	U=2.6dB; k=2

## 7 Test Data and Graph

Only the worst test result was shown in this report.

### 7.1 Radiated Disturbance

#### 30MHz~1GHz



#### MEASUREMENT RESULT: QP Detector

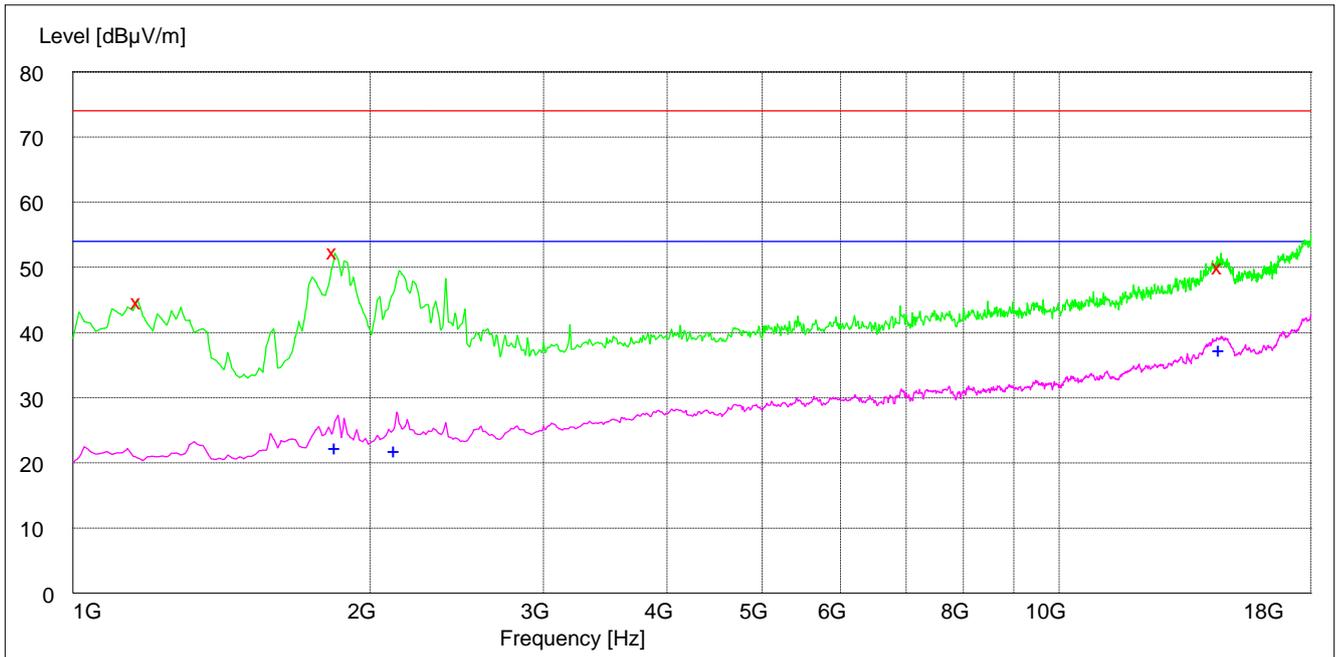
Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Height cm	Azimuth deg	Polarisation
33.180000	22.50	11.8	40.0	17.5	100.0	246.00	VERTICAL
59.640000	23.80	12.5	40.0	16.2	100.0	280.00	VERTICAL
127.440000	30.20	9.6	43.5	13.3	156.0	324.00	HORIZONTAL
190.620000	27.60	12.0	43.5	15.9	100.0	309.00	HORIZONTAL
370.080000	30.50	17.5	46.0	15.5	100.0	108.00	HORIZONTAL
813.660000	35.40	25.1	46.0	10.6	107.0	98.00	HORIZONTAL

Note:

Level = Reading level by receiver + Transd (Antenna factor + cable loss – preamplifier gain)

The reading level is calculated by software which is not shown in the sheet.

### 1GHz~18GHz



#### MEASUREMENT RESULT: PK Detector

Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Height cm	Azimuth deg	Polarisation
1166.200000	44.90	-15.0	74.0	29.1	101.0	351.00	VERTICAL
1842.700000	52.50	-11.4	74.0	21.5	100.0	32.00	VERTICAL
14520.90000	50.30	16.6	74.0	23.7	102.0	64.00	HORIZONTAL

#### MEASUREMENT RESULT: AV Detector

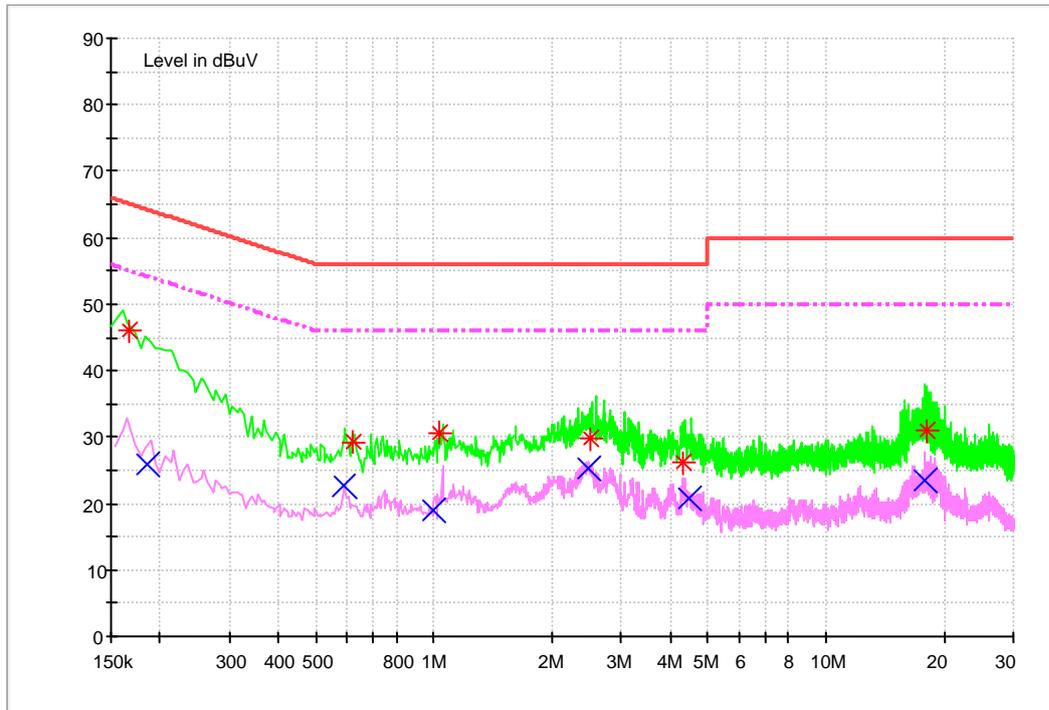
Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Height cm	Azimuth deg	Polarisation
1849.300000	22.60	-11.4	54.0	31.4	102.0	29.00	VERTICAL
2121.300000	22.10	-10.2	54.0	31.9	104.0	235.00	HORIZONTAL
14547.60000	37.60	16.4	54.0	16.4	103.0	328.00	HORIZONTAL

**Note:**

Level = Reading level by receiver + Transd (Antenna factor + cable loss – preamplifier gain)  
The reading level calculated by software which is not shown in the sheet.

## 7.2 Conducted Disturbance

### AC Port TestData



#### MEASUREMENT RESULT: QP Detector

Frequency MHz	Level dB $\mu$ V	Line	Transd dB	Margin dB	Limit dB $\mu$ V	PE
0.166115	46.0	L1	9.7	19.2	65.2	FLO
0.617284	29.1	L1	9.7	26.9	56.0	FLO
1.035232	30.1	L1	9.7	25.9	56.0	FLO
2.517502	29.7	L1	9.7	26.3	56.0	FLO
4.336522	26.1	L1	9.8	29.9	56.0	FLO
18.052440	30.9	N	10.1	29.1	60.0	FLO

#### MEASUREMENT RESULT: AV Detector

Frequency MHz	Level dB $\mu$ V	Line	Transd dB	Margin dB	Limit dB $\mu$ V	PE
0.185674	26.0	L1	9.7	28.2	54.2	FLO
0.593550	22.5	L1	9.7	23.5	46.0	FLO
0.997342	18.9	L1	9.7	27.1	46.0	FLO
2.487855	25.2	L1	9.7	20.8	46.0	FLO
4.443049	20.8	L1	9.8	25.2	46.0	FLO
17.868018	23.4	N	10.1	26.6	50.0	FLO



Note:

Level= Reading level+ Transd (cable loss + correction factor)

The reading level is calculated by software which is not shown in the sheet.

-----END-----